

Substitute for Forms PTO-1449 and PTO/SB/08

U.S. PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE STATEMENT

(Use as many sheets as necessary)

Application No.	09/758,836
Filing Date	January 10, 2001
First Named Inventor	Rick V. Murakami
Art Unit	2612
Examiner Name	Nam V. Nguyen
Attorney Docket No.	36360/1.9

U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No.	Document Number	Publication/ Filing Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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		Country Code* Number* Kind Code (if known)				
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	B2	EP 1 916 615 A1	04-30-2008	Ikegami		

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Examiner Initials*	Cite No.	Include name of the author (in CAPS), title of the article (when appropriate), title of the item (book, magazine, journal, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published. For web pages and online documents, include author or site publisher (in CAPS), title of document, web page address (URL), date published (if known), "visited" date, pages.	T ³ ✓
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